

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/963,396	SMITH ET AL.
Examiner	Art Unit	
EDMUND H. LEE	1732	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
264	510,553	8/8/2005	EHL
	247,250		
	210.1		
425/388,127			